Rec'd PCT/PTO 12 OCT 2004

(12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(19) World Intellectual Property Organization

International Bureau

(43) International Publication Date 18 December 2003 (18.12.2003)



PCT

(10) International Publication Number WO 2003/103364 A3

(51) International Patent Classification: H01L 31/00

G01J 5/30,

PCT/IL2003/000414

(21) International Application Number:

21 May 2003 (21.05.2003)

(25) Filing Language:

English

(26) Publication Language:

(22) International Filing Date:

English

(30) Priority Data: 150058

6 June 2002 (06.06.2002)

- (71) Applicant (for all designated States except US): SEMI CONDUCTOR DEVICES (SCD) PARTNERSHIP [IL/IL]; Leshem, Regional Council of Misgav (IL).
- (72) Inventors; and
- (75) Inventors/Applicants (for US only): ELKIND, Shimon [IL/IL]; 11a, Mishol Moran, 20100 Carmiel (IL). ADIN, Amnon [IL/IL]; 22, Harel Street, 34555 Haifa (IL).

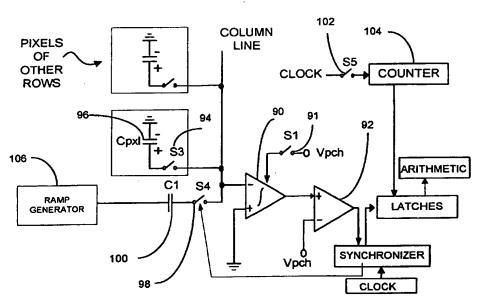
- (74) Agent: TSIVION, Yoram; P.O.Box 1307, 37111 Pardes Hanna (IL).
- (81) Designated States (national): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NI, NO, NZ, OM, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.
- (84) Designated States (regional): ARIPO patent (GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT, LU, MC, NL, PT, RO, SE, SI, SK, TR), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

Published:

with international search report

[Continued on next page]

(54) Title: FOCAL PLANE PROCESSOR FOR IR DETECTION



(57) Abstract: A focal plane array detector in a sensor for IR imaging. Pixel readout and analog to digital conversion is performed in an integrated circuit which includes the imaging array. The charge of each pixel is accumulated in a capacitor (16) and a digital to analog charge converter cancels this charge. A controller controls this charge converter providing the appropriate amount of charge. An analog to digital converter incorporating a comparator (92) switches the controller on/off. In some embodiment a programmable device external to the sensor participates in the control of the analog to digital converter. In a typical em-bodiment of the invention a cycle generator controls the charge output of the digital to analog converter. In a preferred embodiment the analog to digital converters are grouped wherein all such converters group operate simultaneously.